((Titelbild wie beim alten Datenblatt))

CCVS + Component Generator SAF CCVS Generator SFF

Multi-standard generators for all TV applications

- Several hundred test signals to suit every application
- Easy definition of additional signals via front panel, storage in built-in RAM or on memory card
- Setting of amplitude, H/V and colour subcarrier frequency as well as of other signal parameters
- Genlock operation: selection of phase between input signal and generator signal
- Insertion of internally generated test, data and teletext lines as well as of signals from a maximum of two external sources
- System compatibility thanks to IEC 625/IEEE 488 bus



Characteristics

The TV Generators SAF and SFF are two multi-standard instruments suitable for all applications in the field of television. They provide signals according to the BG/PAL and M/NTSC standards which are used worldwide and also generate signals to M/PAL and N/PAL standards.

The CCVS + Component Generator SAF supplies test signals in CCVS, YC_BC_R , RGB and S-VHS formats, for test patterns an aspect ratio of 4:3 or 16:9 being selectable for the adjustment of monitors. Where the CCVS format is required only, the attractively priced CCVS Generator SFF can be used. In both generators the digital signal format to CCIR 601 can optionally be implemented in parallel and serial form.

Both generators allow complex signal variations via menus:

AMPLITUDE

- CCVS, CVS, chroma, sync, burst, setup and YC_BC_R can be varied continuously
- The RGB channels can be switched off individually; a sync pulse can be added to each of these components

PHASE/TIME

- Setting the SC/H phase
- The synchronized mode enables the user to select the timing of the generator signal with respect to the program signal as well as the phase of the generator colour subcarrier relative to the program colour subcarrier
- Varying the horizontal frequency by ±5%
- Free setting of colour subcarrier frequency in range 100 Hz to 6 MHz
- Selection of burst duration, position and rise time as well as of sync duration and rise time

SIGNAL EDIT

 Definition of signals via front panel and storage in built-in, batterybacked RAM or externally on memory card

A signal line is described as a list of signal elements using a simple language. All parameters of the signal elements can be varied separately by means of the spinwheel or the keyboard. The generator output signal reflects the variation of parameters. For instance, it is thus possible to change the amplitude of the luminance bar to test amplitude control circuits, white-level limiters or video analyzers over the whole range of the device under

The large-size EL display and softkeys make complex signal variations, eg of amplitude, easy...



...and enable time-related settings like phase and reference clock ...

...or burst and sync pulse

The different setting menus can be called up with a keystroke

called up with a keystroke

test. The frequencies of individual sinewave burst elements, phase, timing and rise times can also be varied easily and rapidly.

The full field (pattern) is defined similarly by listing line commands. This can be done using user-defined or factory-stored test lines.

Another way of editing signals is by forming sequences of predefined patterns. Test signals made up of moving elements can thus be defined.

SIGNAL VARIATION))

((Frontplattendetail

SETUP

- Switchover between BG/PAL, M/NTSC, M/PAL and N/PAL standards
- Free programming of test-line coding and monitoring
- Teletext and data line insertion
- Dataline coder
- Superimposed hum (frequency, amplitude and waveform selectable)
- Superposition of external signal
- Entry of customer-specific texts as source identification or scrolling text
- Program monitoring + substitution pattern
- General device setups

STO/RCL

- Storage of device setups and signals in built-in, battery-backed RAM or externally on memory card
- Recall of device setups or signals from built-in RAM or memory card
- Copying from and to RAM and memory card

STATUS

- Indication of current device setup
- Four keys with definable functions for fast callup of frequently used functions

Use in digital TV studios

The optional digital video interface to CCIR 601 makes SAF and SFF suitable for use in digital TV studios. In addition to the analog video signals, a parallel and two serial digital video signals are thus simultaneously available. The generators furthermore produce all test signals to CCIR Rec. 801, a variety of common pathological test signals as well as shallow ramps with 10-bit resolution. The timing of the reference clock at the parallel digital output can be shifted relative to the video data. All amplitude variations (except sync and burst) also influence the data contents of the digital video signals.

Description

The generator section of TV Generators SAF and SFF is of digital design. A transputer – a high-speed RISC processor – calculates the three components Y, C_B and C_R of all test signals which in CCVS + Component Generator SAF are applied to three D/A converters. An analog matrix converts the three components into the RGB format. Therefore the RGB signals are always made available simultaneously with the YC $_B$ C $_R$ components. The digital CCVS in the SAF and SFF is determined from the YC $_B$ C $_R$ components in realtime with the aid of two LSI gate arrays.

The first array ensures accurate digital coupling of line and colour subcarrier frequency, while the second array acts as a digital colour subcarrier modulator. Strict compliance with the SC/H phase for the BG/PAL, M/NTSC, M/PAL and N/PAL standards is thus always ensured.

For the S-VHS format, the Y component of the CCVS is digitally switched off. The resulting chroma signal yields together with the Y component of the YC_BC_R signal the S-VHS format.

The test signals defined in accordance with CCIR and FCC/NTSC as well as all other test signals including user-defined signals can be inserted into the blanking intervals of the internal generator signal or of any program signal.

Synchronization of the generator signal with the program signal takes account of the correct allocation of the 8(4)-field sequence in BG/PAL (M/NTSC). If the program signal is not to standard, it is thus always ensured that the generator signal complies with the standard.

12 signal groups can be selected via the front-panel keys:

ITS

All test signals to CCIR, FCC or national standards

APL

Average picture level: 3/4 lines monochrome, one selectable signal line; bounce

SPECIAL

Split level, coring, sin x/x, bowtie and many other special signals, optional PALplus test pattern

12 different signal groups can be called up via the front panel

((Frontplattendetail SIGNAL GROUP))

SWEEP-BURST

H and V sweep, multiburst, V sweep with adjustable marker, sinewave signal with selectable frequency (linecoupled phase)

PULSE BAR

Squarewave and cos² pulses

LINEARITY

Sawtooth and staircase signals

MONITOR ADJUSTMENT

Test patterns 4:3 and 16:9, colour bars, pluge, crosshatch

ZONE PLATE

Linear, circular and hyperbolic zone plates, variable zone plate signal with freely selectable coefficients k_x , k_{x2} , k_{xy} , k_y , k_{y2} ; coefficients k_{Φ} , k_{t} , k_{t2} freely adjustable for every zone plate

CCIR 601 (option)

Signals to CCIR Rec. 801, pathological signals, digital shallow ramps

CARD SIGNALS

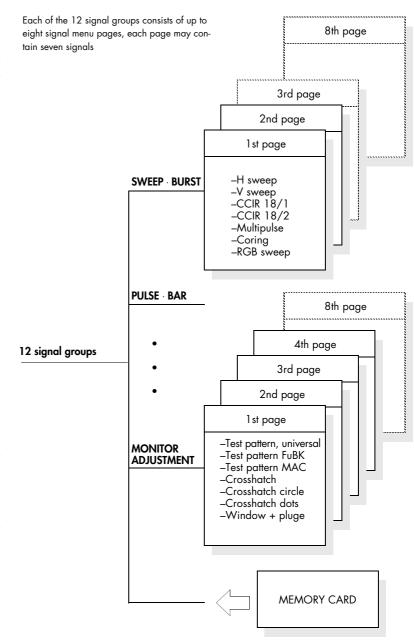
All signals stored on plugged-in memory card

USER SIGNALS

All signals stored in RAM

USER SET

The last seven signals selected; this set can be "frozen" at any time



Rear view of SAF



Specifications

Inputs/outputs Return loss Sync output SC (colour subcarrier) Bounce trigger (input)

Bypass

EXT inputs

Connector Gain Differential gain Differential phase Clamping modes

Superposition (EXT2 only)

Amplitude adjustment

Phase/time adjustment $\begin{array}{l} H_{INT} - H_{EXT} \\ SC_{INT} - SC_{EXT} \\ SC/H \ phase \end{array}$

Horizontal frequency Colour subcarrier frequency Burst position, duration, rise time, sync duration, rise time

Program path (Genlock)

Input/output Amplitude-frequency response Group-delay error Differential gain Differential phase S/N ratio (rms, weighted, 0.2 to 5 MHz) Test signal insertion

Insertion range in 1st field in 2nd field

Teletext signals

Amplitude V_{pp} Eye height Ćlock

Data lines

Amplitude V_{pp} Coding Clock

Remote-control interface

BNC female connectors, 75 Ω \geq 34 dB (up to 6 MHz) 2 V into 75 Ω

2 V fine 75 Ω 2 Vpp into 75 Ω TTL levels, $Z_{\rm in}$ approx. 10 k Ω , for external triggering of bounce function 0 V/5 V for controlling the bypass circuit in a junction panel, Z_{out} approximately 20 Ω

2 inputs for inserting external signals into test line range or superimposing an external signal on the generator

signals BNC, $75~\Omega$ $0 \pm 0.1 \, dB$ ≤0.3% ≤0.3°

- gated clamping to back porch clamping to negative signal peak (EXT2 only)

AC-coupled signal (EXT2 only)

- anywhere

- in active picture range

via front panel or IEC/IEEE bus, variable in the range 0 to 140%¹) are the signal components CCVS CVS, chroma, sync pulse, burst, setup and components Y, C_B, C_R

±9 μs 0 to 360° -180° to $+180^{\circ}$ $\pm 5\%$ (burst switched off from +1.5%) 100 Hz to 6 MHz

setting range of a parameter always depending on settings of other param-

BNC, 75 Ω ± 0.1 dB (up to 6 MHz) ≤5 ns (up to 5.5 MHz) < 0.2%

<0.2° ≥78 dB

same as generator signal - CAL (normal mode) - setting of CVS up to $V_{pp} = 1.2 \text{ V}$, for testing automatic gain control circuits, video analyzers, etc.

BG/PAL, M/NTSC M/PAL N/PAL lines 6 to 22 10 to 22 10 to 22 319 to 335 10 to 21 273 to 284

5 pages and teletext meas. eve test pattern and teletext meas. line line 462 ± 5 mV $500 \pm 5 \text{ mV}$ ≥96% ≥96% 6.9375 MHz 5.72727 MHz

4 sequences programmable via front panel and IEC/IEEE bus $500 \pm 5 \,\, \text{mV}$ biphase coding 5 MHz

to IEC 625-2 (IEEE 488), for controlling all generator functions

CCVS

Level tolerances Standard BG/PAL, N/PAL M/NTSC, M/PAL 700 ± 4 mV 700 ± 7 mV Nominal luminance level (cal.) 714 ± 4 mV 714 ± 7 mV Nominal chrominance level (cal.) Departure at nominal 500 to 700 mV ±1% +1% at nominal <500 mV ±5 mV ±5 mV Squarewave pulses, staircase and sawtooth signals nominal ± 4 mV nominal + 4 mV nominal \pm 5 mV nominal + 5 mV2T pulse 10T and 20T pulses nominal $\pm 7 \text{ mV}$ nominal $\pm 7 \text{ mV}$ nominal $\pm 7 \text{ mV}$ 12.5T pulses

Amplitude-frequency response Multipulse, multiburst,

up to 5.5 MHz sweep signals ±0.1 dB 5.5 to 6 MHz ±0.15 dB

Group delay

10T and 20T pulses (modulated with frequencies ≤5 MHz) <5 ns

Rise times (10 to 90%) and half-amplitude duration

(also for YC_BC_R signals) Sync rise time 200 ± 5 ns (PAL, 625 lines) 140 ± 5 ns (NTSC, 525 lines)

125 to 2000 ns Luminance rise times tolerances 125 to 249 \pm 5 ns 250 to 999 ± 10 ns 1000 to 2000 $\pm\,30$ ns 150 to 2000 ns Chrominance rise times

tolerances $150 \text{ to } 299 \pm 5 \text{ ns}$ $300 \text{ to } 999 \pm 10 \text{ ns}$ $1000 \text{ to } 2000 \pm 30 \text{ ns}$

Line-time nonlinearity

5-step staircase ≤0.8%

Chrominance phase

90° ± 1° Phase between R-Y and B-Y axes Maximum departure of chrominance phase from nominal +2°

S/N ratio

rms, weighted, 0.2 to 5 MHz Measured on all-black picture >78 dB >70 dBMeasured on sawtooth signal

Sync frame NTSC sync frame and coupled with burst phase to stable SC/H CCIR Rec. 624-3 phase (to RS-170 A) SC/H phase (calibrated) 0 ± 5° $0 + 5^{\circ}$

can be disabled for special measurements

The tolerances in S-VHS format correspond to those of CCVS

Component signals

V component

YC _B C _R (for 525/625 lines, not in SFF) Squarewave, staircase signals Sawtooth signals 2 to 20T pulses 3 to 20T pulses Sweep, multiburst signals 0 to 5.5 MHz	Y signal nominal ± 4 mV nominal ± 7 mV nominal ± 7 mV -	C _B , C _R signal nominal ±7 mV nominal ±7 mV nominal ±7 mV
5.5 to 6 MHz		nominal \pm 10 mV

Each component can be disabled separately; the rise times are determined by those of the YC $_B\text{C}_R$ signals Ámplitude error same as YC_BC_R signal components Matrixing error ±0.2 dB (up to 6 MHz) Matrixing frequency response Sync pulse (can be added to or removed from each component) $300 \pm 7 \text{ mV}$

 $^{^{1}}$) The CCVS must not exceed 1.6 V_{pp}

Option CCIR 601 Standards

Systems

Signals

625 lines/50 Hz, 525 lines/60 Hz CCIR Rec. 601/656 (4:2:2) SMPTE 125M/259M

- to CCIR Rec. 801 with 10-bit resolution
- pathological signals for testing the serial digital interface with 10-bit resolution
- digital shallow ramps with 10-bit resolution
- resolution

 all other SAF/SFF signals with 9-bit resolution; the 10th bit can be switched to 0, 1 or to alternating 0/1 operation for each Y, C_B and C_R component

Outputs
1 parallel output Amplitude Rise/fall time (20%/80%) Clock pulse width Clock/data delay Clock/data setting range Connector

2 serial outputs Amplitude Rise/fall time (20%/80%) Output impedance Return loss Connector

27 Msample/s ECL level <5 ns 18.5 ns ±3 ns 18.5 ns ±3 ns $\pm 10 \text{ ns}$ 25-contact Sub D (ISO 2110-1980)

270 Mbit/s (D1 format) 800 mV $_{pp}$ ±10% into 75 Ω 0.75 to 1.5 ns 75Ω ≥15 dB from 10 to 270 MHz

General data

Operating temperature range Storage temperature range Mechanical resistance Sinusoidal vibration

Random vibration Shock

Climatic resistance

Electromagnetic compatibility

Electrical safety Power supply

Dimensions (W x H x D)

Weight

Ordering information

Order designation CCVS + Component Generator CCVS Generator	SAF SFF	2007.1005.02 2007.1057.02
Options Digital Video Interface PALplus Test Pattern	SAF-Z1 SFF-Z1 SAF-B20	2007.1063.02 2007.1063.03 2007.1011.02
Accessories supplied	power cable, fuses	
Recommended extras Memory Card 32 Kbyte Memory Card 512 Kbyte Service Kit (containing adapter boards, adapter cable and	ZZM-32 ZZM-512	2005.4394.02 2005.4388.02
service manual) Handles and screws	SAF-Z SFF-Z	2007.1111.00 2007.1105.00 0396.5153.00

Certified Quality System DQS REG. NO 1954-02

+5 to +45 $^{\circ}\text{C}$ -40 to +70 °C

5 to $150~\rm{Hz},~\rm{max}.~2~g$ at $55~\rm{Hz},~0.5~g$ from $55~\rm{to}~150~\rm{Hz},~\rm{to}~\rm{IEC}~68\text{-}2\text{-}6,~\rm{IEC}~1010\text{-}1,~\rm{}$ MIL-T-28800 D class 5 10 to 300 Hz, 1.2 g_{rms} 40 g shock spectrum, to MIL-STD 810 C and MIL-T-28800 D classes 3 and 5

+25/+40 °C cyclic at 95% rel. humidity, to IEC 68-2-30 to EMC directive of EU (89/336/EEC) and German EMC law to EN 61010-1 100/120/230/240 V +10/-15%, 47 to 63 Hz, 100 VA (SAF), 80 VA (SFF) 435 mm x 147 mm x 460 mm SAF: 16.5 kg SFF: 15.5 kg

